

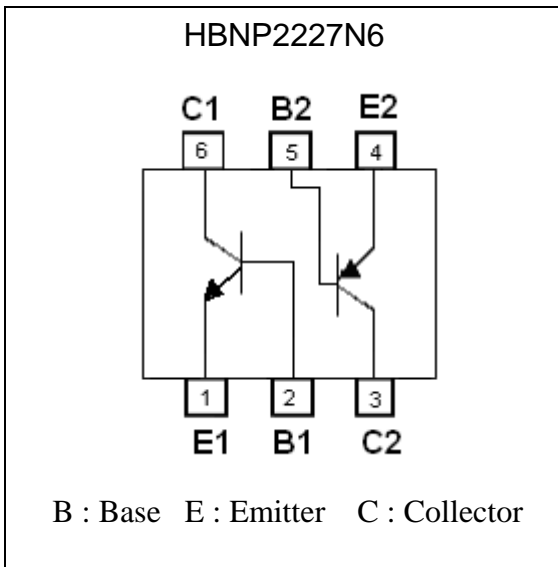
NPN AND PNP Dual Epitaxial Planar Transistors

HBNP2227N6

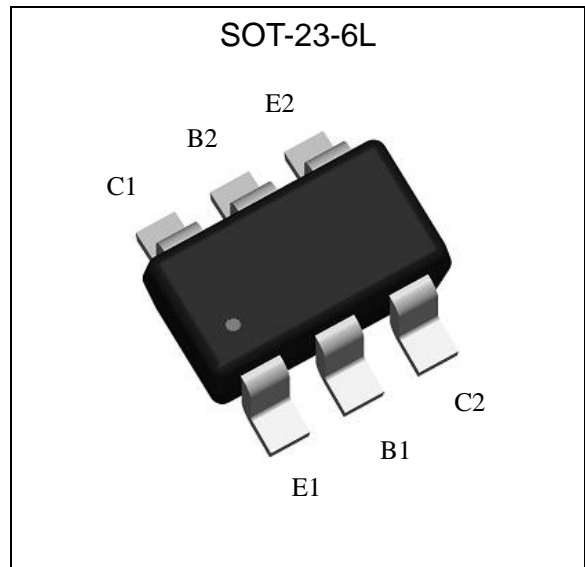
Features

- Includes a PN2222A chip and PN2907A chip in a SOT-23-6L package.
- Mounting possible with SOT-23 automatic mounting machines.
- Transistor elements are independent, eliminating interference.
- Mounting cost and area can be cut in half.
- Pb-free lead plating package.

Equivalent Circuit

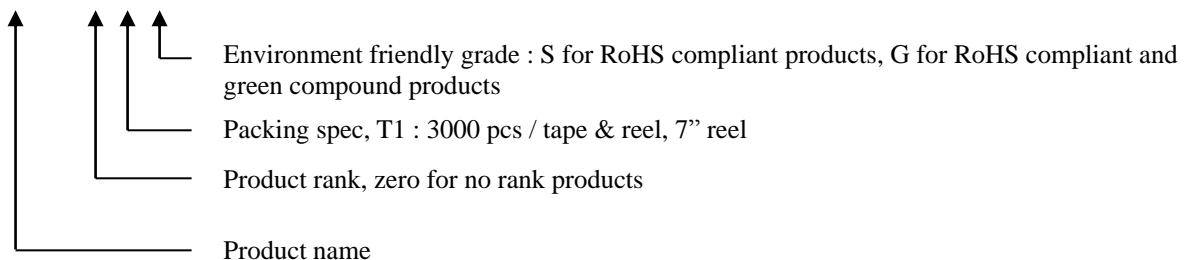


Outline



Ordering Information

| Device | Package | Shipping |
|-------------------|--|------------------------|
| HBNP2227N6-0-T1-G | SOT-23-6L (Pb-free lead plating and halogen-free package) | 3000 pcs / tape & reel |





Absolute Maximum Ratings (Ta=25°C)

| Parameter | Symbol | Limits | | Unit |
|--|-----------------------------------|----------|------|------|
| | | NPN | PNP | |
| Collector-Base Voltage | V _{CB0} | 75 | -60 | V |
| Collector-Emitter Voltage | V _{CEO} | 50 | -60 | V |
| Emitter-Base Voltage | V _{EBO} | 6 | -6 | V |
| Collector Current(DC) (Note 1) | I _C | 600 | -600 | mA |
| Peak Collector Current (Note 2) | I _{CP} | 1.2 | -1.2 | A |
| Peak Base Current (Note 2) | I _{BP} | 100 | -100 | mA |
| Total Power Dissipation (Note 1) | P _D | 1.14 | | W |
| Linear Derating Factor | | 0.01 | | |
| Operating Junction and Storage Temperature | T _j , T _{stg} | -55~+150 | | °C |
| Thermal Resistance, Junction-to-Ambient (Note 1) | R _{th,ja} | 110 | | °C/W |

Note : 1.Surface mounted on 1 in² copper pad of FR-4 board, t≤5 sec; 180°C/W when mounted on minimum copper pad
 2.Pulse width limited by maximum junction temperature

NPN Electrical Characteristics (Tj=25°C, unless otherwise specified)

| Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|-----------------------|------|------|------|------|--|
| B _V CB0 | 75 | - | - | V | I _C =10μA |
| B _V CEO | 50 | - | - | V | I _C =10mA |
| B _V EBO | 6 | - | - | V | I _E =10μA |
| I _C B0 | - | - | 10 | nA | V _{CB} =60V |
| I _C EX | - | - | 10 | nA | V _{CE} =60V, V _{EB} =3V |
| I _E B0 | - | - | 100 | nA | V _{EB} =6V |
| *V _{CE(sat)} | - | - | 0.3 | V | I _C =150mA, I _B =15mA |
| *V _{CE(sat)} | - | - | 0.5 | V | I _C =500mA, I _B =50mA |
| *V _{BE(sat)} | - | - | 1.2 | V | I _C =150mA, I _B =15mA |
| *V _{BE(sat)} | - | - | 1.5 | V | I _C =500mA, I _B =50mA |
| h _{FE} | 35 | - | - | - | V _{CE} =10V, I _C =100μA |
| h _{FE} | 50 | - | - | - | V _{CE} =10V, I _C =1mA |
| h _{FE} | 75 | - | - | - | V _{CE} =10V, I _C =10mA |
| *h _{FE} | 100 | - | 300 | - | V _{CE} =10V, I _C =150mA |
| *h _{FE} | 35 | - | - | - | V _{CE} =1V, I _C =150mA |
| *h _{FE} | 40 | - | - | - | V _{CE} =10V, I _C =500mA |
| f _T | 300 | - | - | MHz | V _{CE} =20V, I _C =20mA, f=100MHz |
| C _{ob} | - | - | 8 | pF | V _{CB} =10V, f=1MHz |

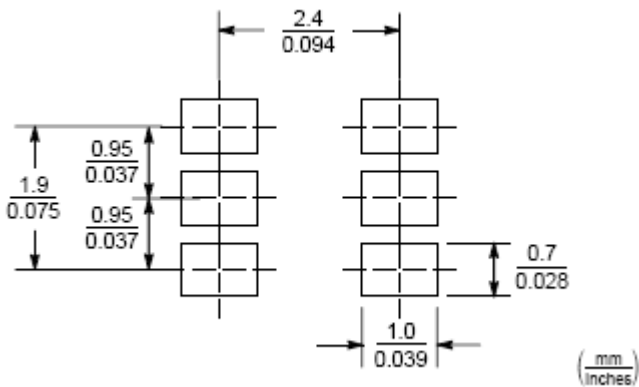
*Pulse Test: Pulse Width ≤380μs, Duty Cycle≤2%

PNP Electrical Characteristics (Tj=25°C, unless otherwise specified)

| Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|-----------------------|------|------|------|------|--|
| BV _{CB0} | -60 | - | - | V | I _C =-10μA |
| BV _{CEO} | -60 | - | - | V | I _C =-10mA |
| BV _{EB0} | -6 | - | - | V | I _E =-10μA |
| I _{CB0} | - | - | -10 | nA | V _{CB} =-50V |
| I _{CEx} | - | - | -50 | nA | V _{CE} =-30V, V _{EB} =-0.5V |
| I _{EBO} | - | - | -100 | nA | V _{EB} =-6V |
| *V _{CE(sat)} | - | - | -0.4 | V | I _C =-150mA, I _B =-15mA |
| *V _{CE(sat)} | - | - | -1 | V | I _C =-500mA, I _B =-50mA |
| *V _{BE(sat)} | - | - | -1.2 | V | I _C =-150mA, I _B =-15mA |
| *V _{BE(sat)} | - | - | -1.5 | V | I _C =-500mA, I _B =-50mA |
| h _{FE} | 75 | - | - | - | V _{CE} =-10V, I _C =-100μA |
| h _{FE} | 100 | - | - | - | V _{CE} =-10V, I _C =-1mA |
| h _{FE} | 100 | - | - | - | V _{CE} =-10V, I _C =-10mA |
| *h _{FE} | 100 | - | 300 | - | V _{CE} =-10V, I _C =-150mA |
| *h _{FE} | 50 | - | - | - | V _{CE} =-10V, I _C =-500mA |
| f _T | 200 | - | - | MHz | V _{CE} =-20V, I _C =-50mA, f=100MHz |
| C _{ob} | - | - | 8 | pF | V _{CB} =-10V, f=1MHz |

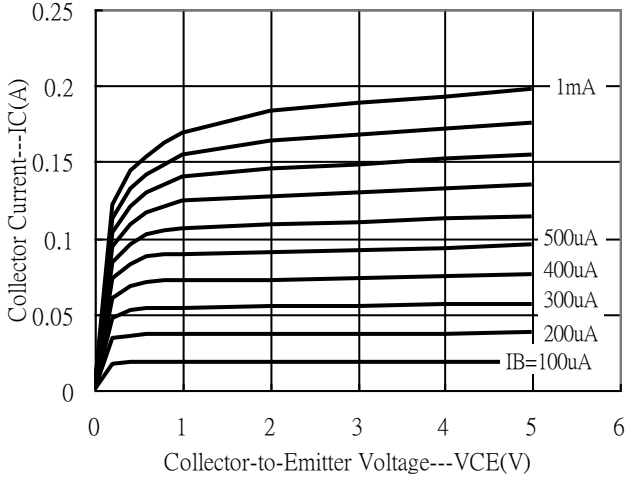
*Pulse Test: Pulse Width ≤380μs, Duty Cycle ≤2%

Recommended Soldering Footprint

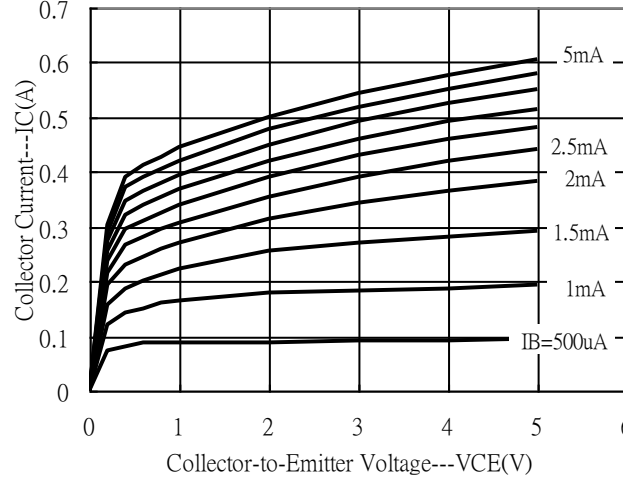


Q1, NPN Typical Characteristics

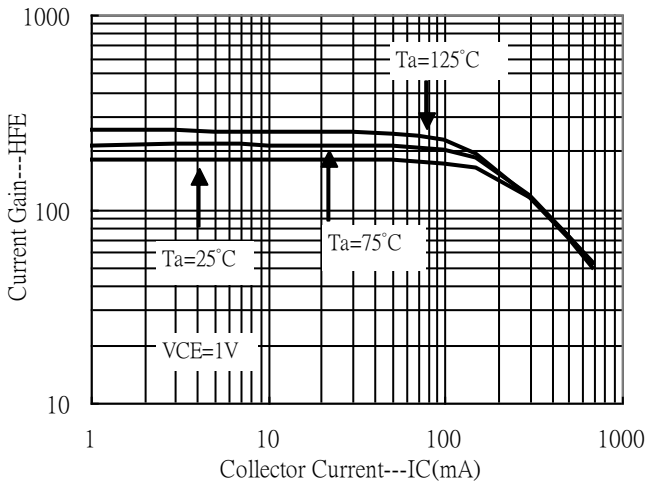
Emitter Grounded Output Characteristics



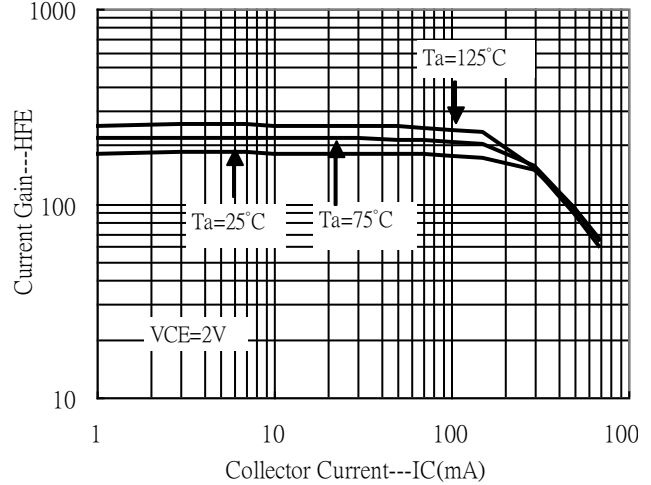
Emitter Grounded Output Characteristics



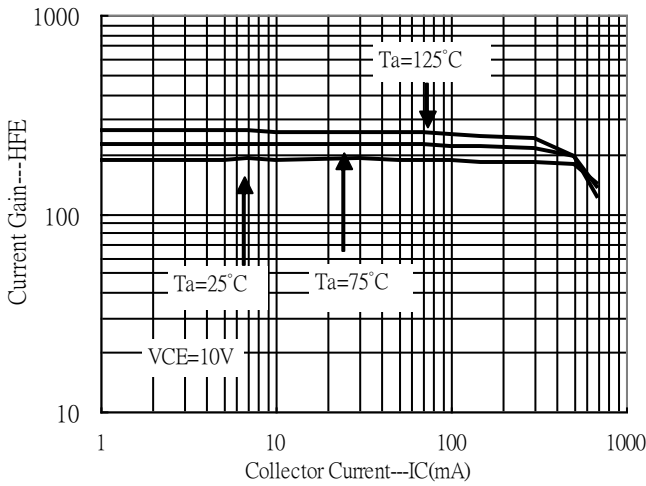
Current Gain vs Collector Current



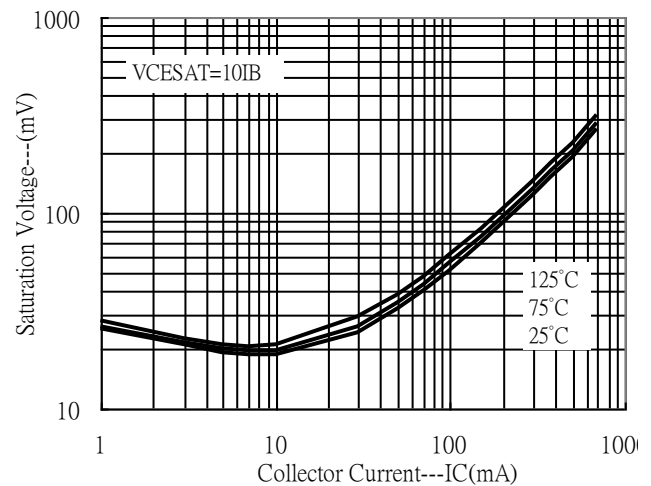
Current Gain vs Collector Current



Current Gain vs Collector Current

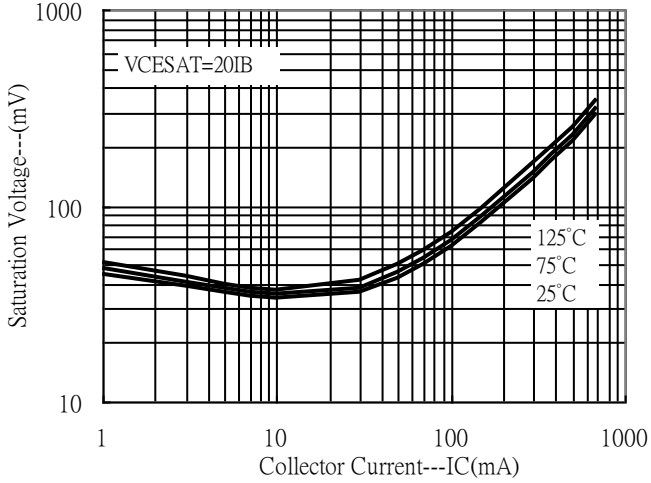


Saturation Voltage vs Collector Current

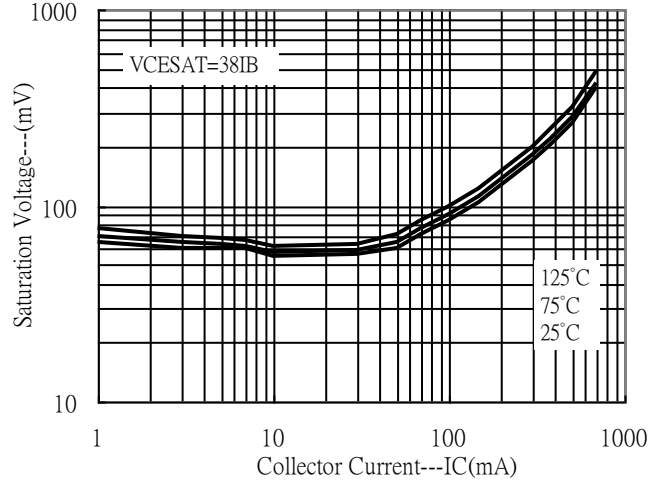


Q1, NPN Typical Characteristics (Cont.)

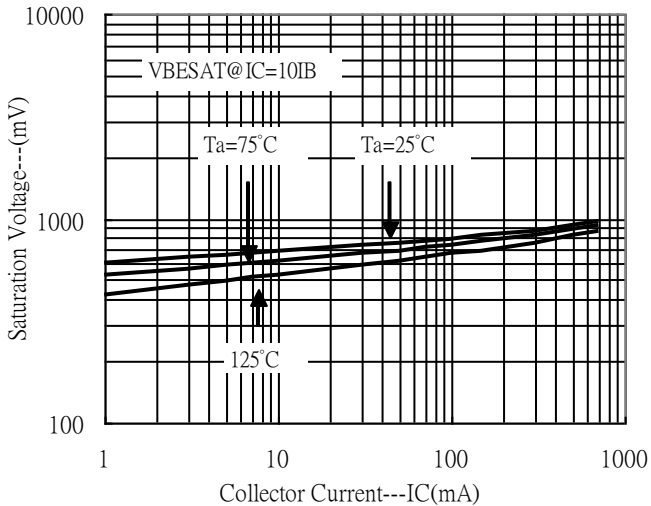
Saturation Voltage vs Collector Current



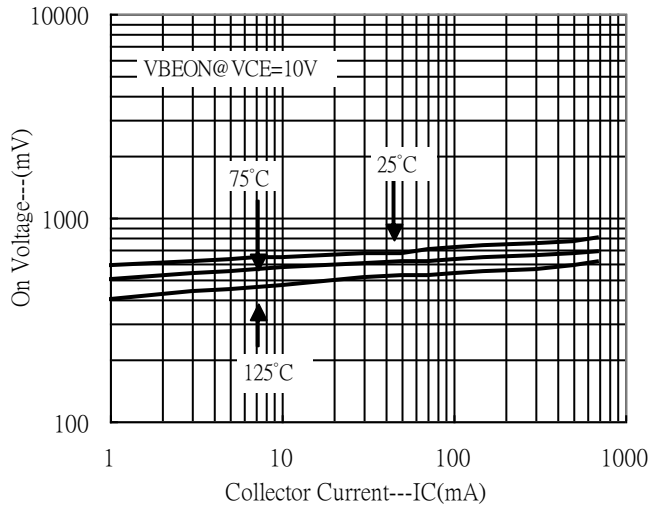
Saturation Voltage vs Collector Current



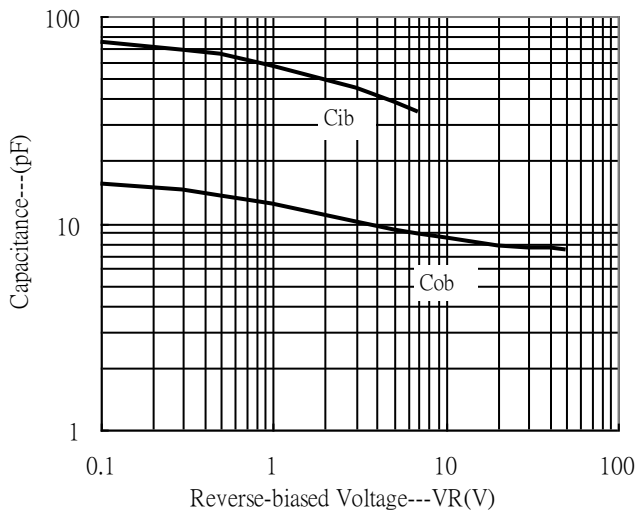
Saturation Voltage vs Collector Current



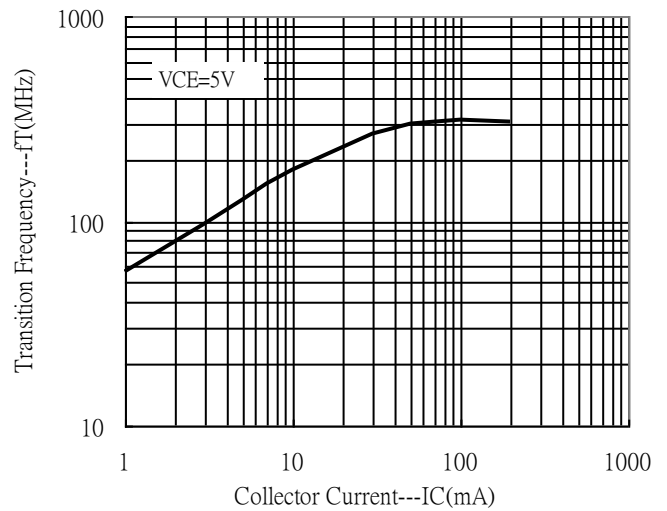
On Voltage vs Collector Current



Capacitance vs Reverse-biased Voltage

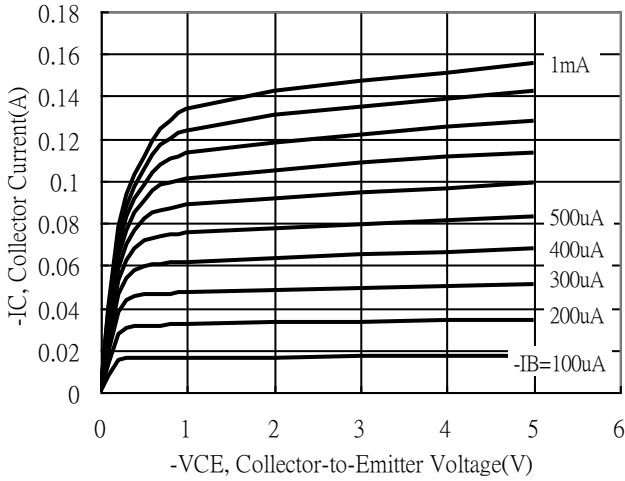


Transition Frequency vs Collector Current

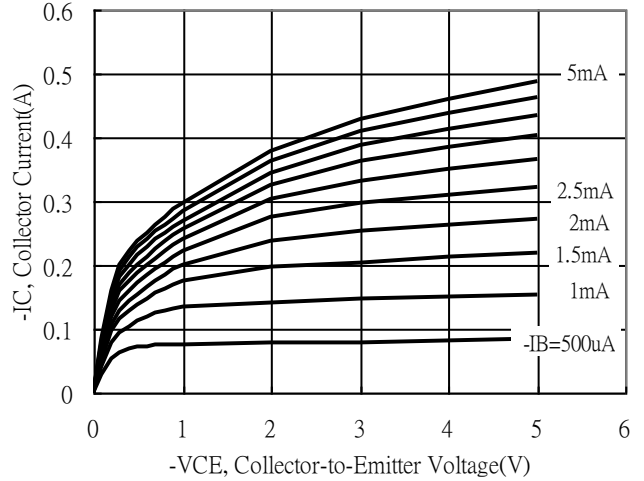


Q2, PNP Typical Characteristics

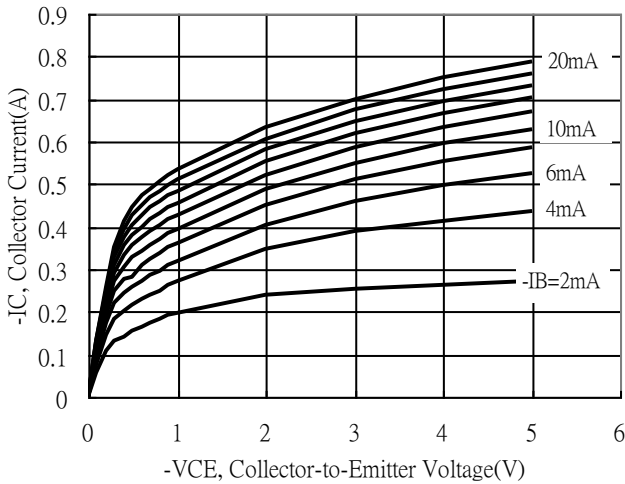
Emitter Grounded Output Characteristics



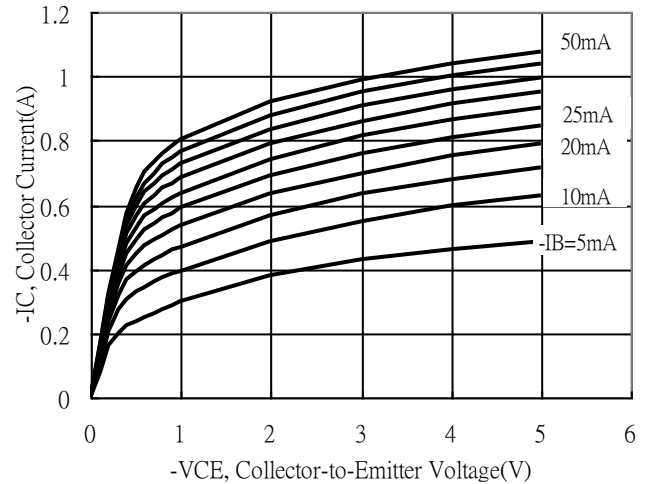
Emitter Grounded Output Characteristics



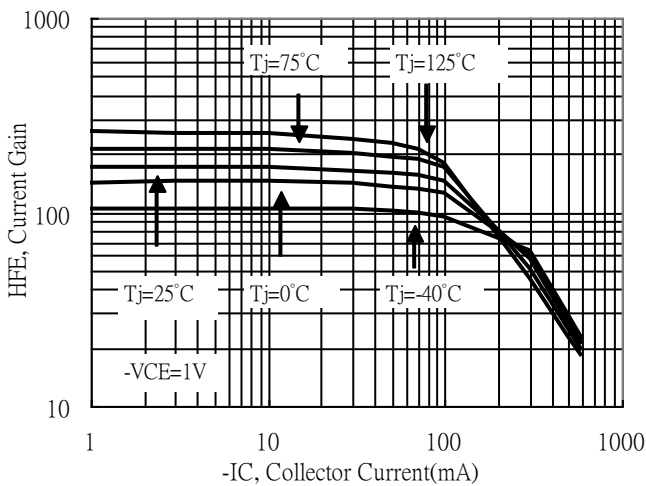
Emitter Grounded Output Characteristics



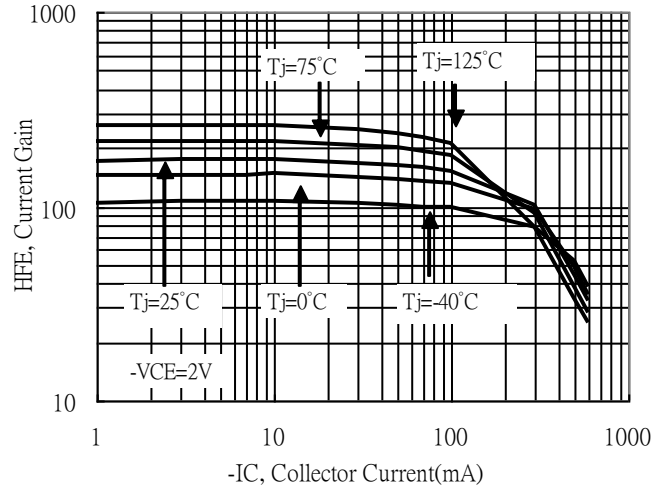
Emitter Grounded Output Characteristics



Current Gain vs Collector Current

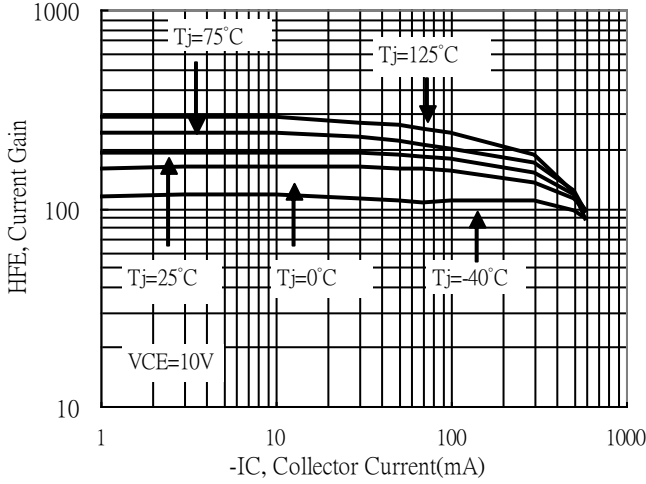


Current Gain vs Collector Current

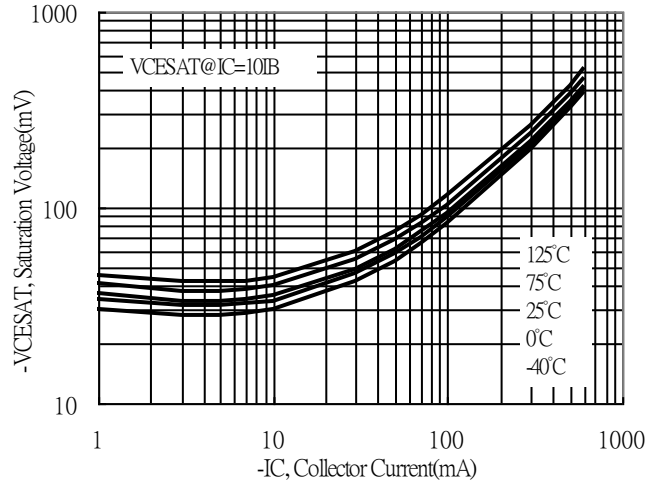


Q2, PNP Typical Characteristics (Cont.)

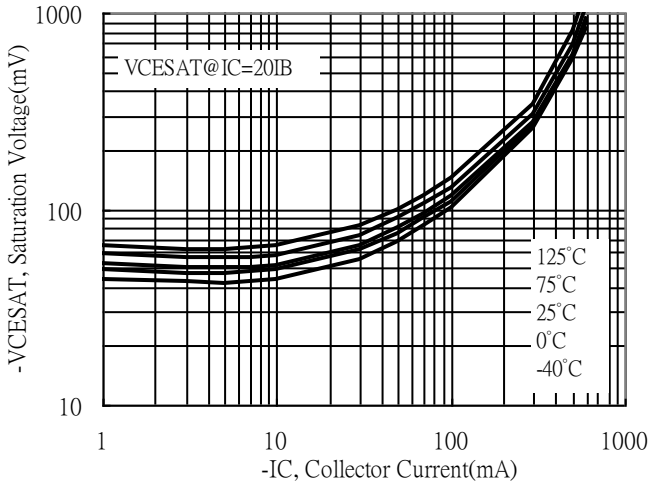
Current Gain vs Collector Current



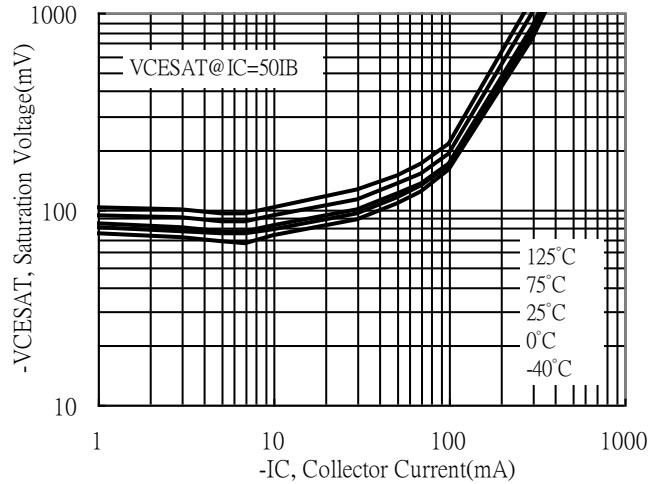
Saturation Voltage vs Collector Current



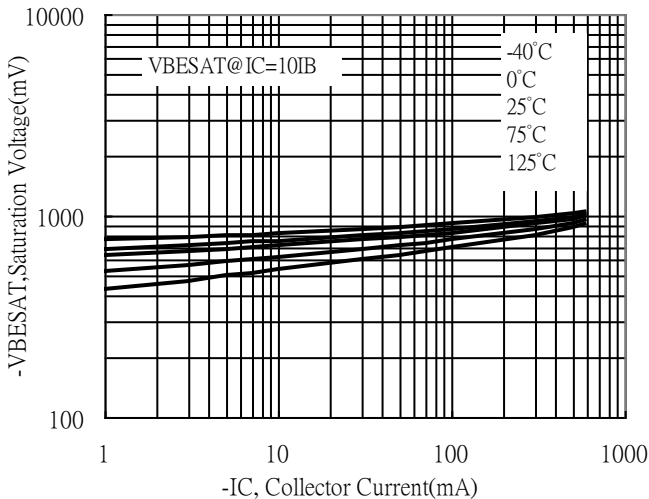
Saturation Voltage vs Collector Current



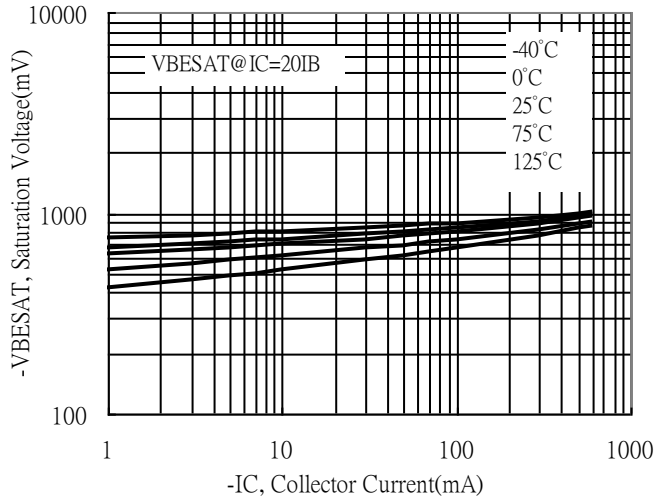
Saturation Voltage vs Collector Current



Saturation Voltage vs Collector Current

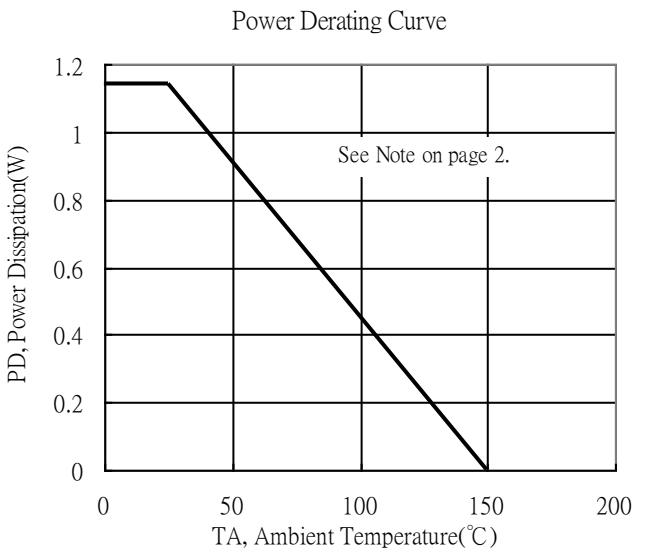
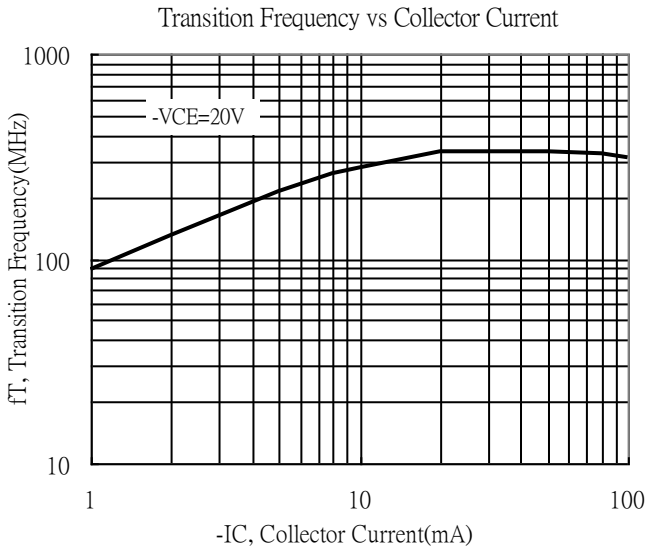
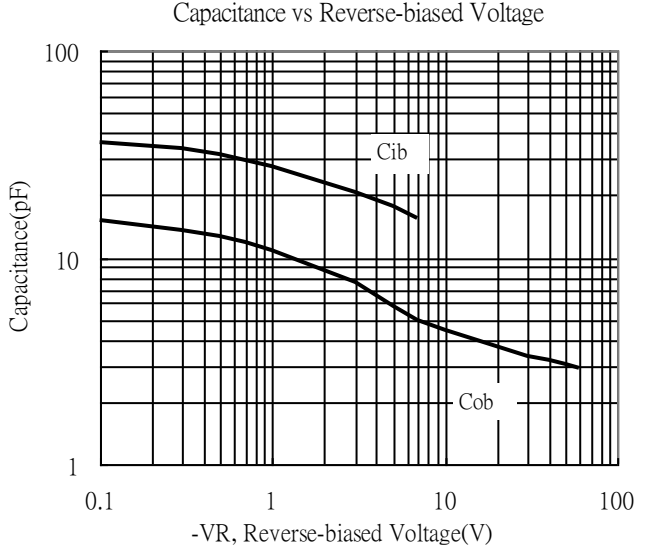
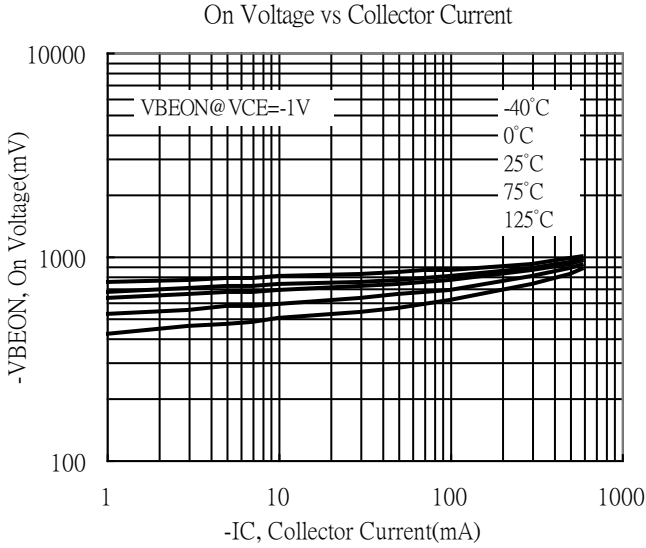


Saturation Voltage vs Collector Current

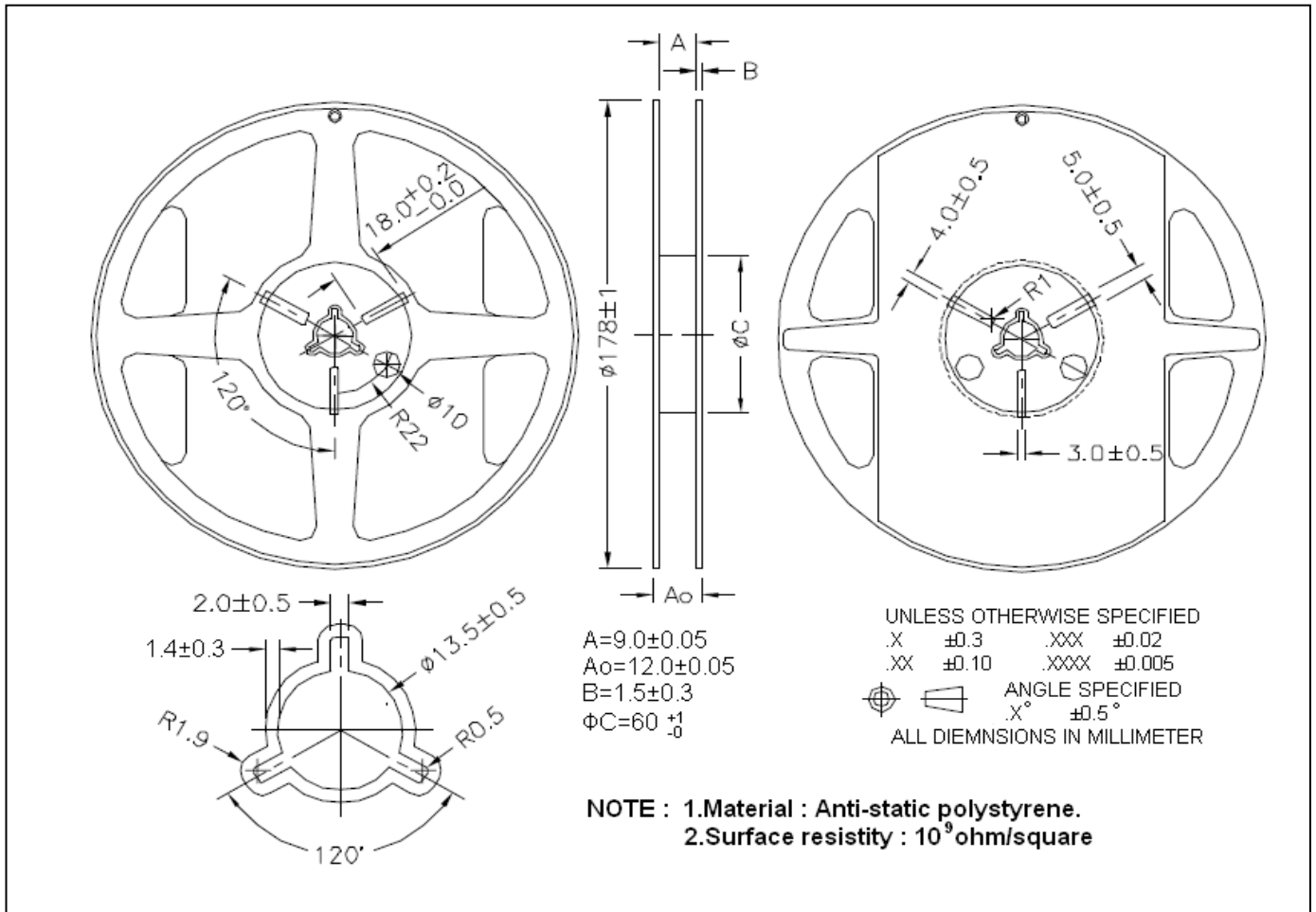




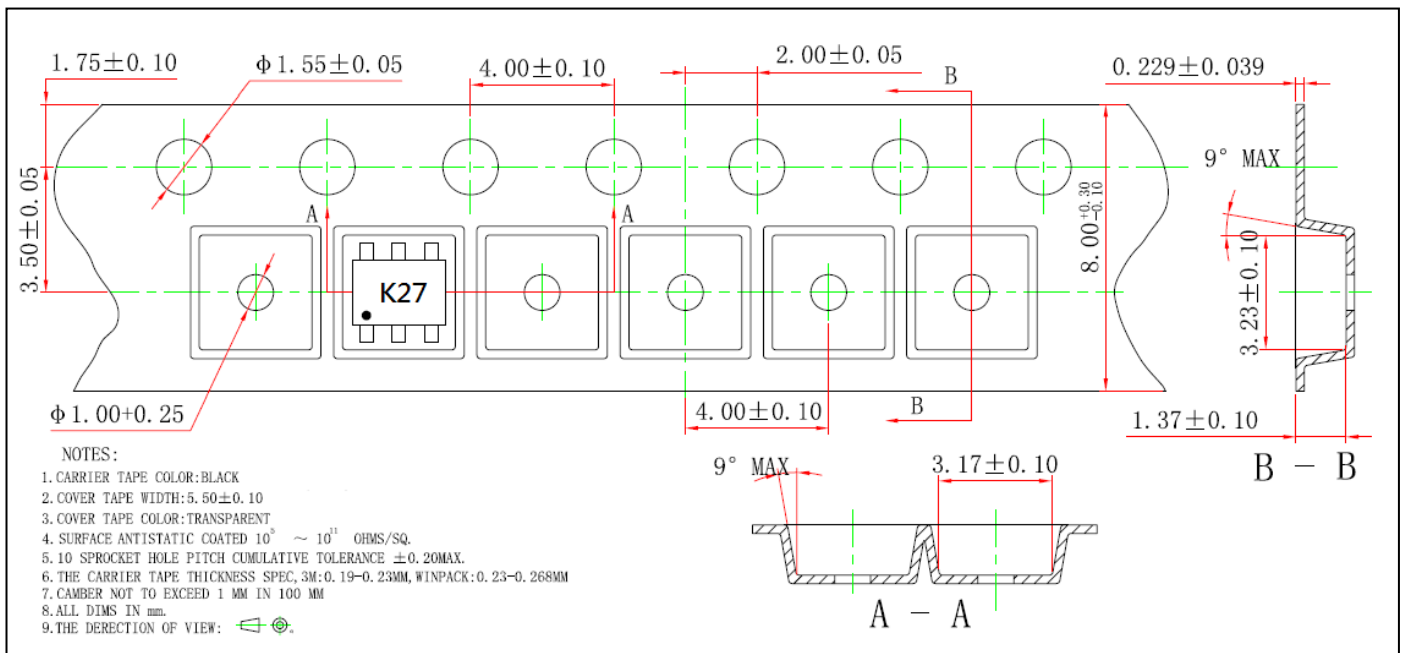
Q2, PNP Typical Characteristics (Cont.)



Reel Dimension



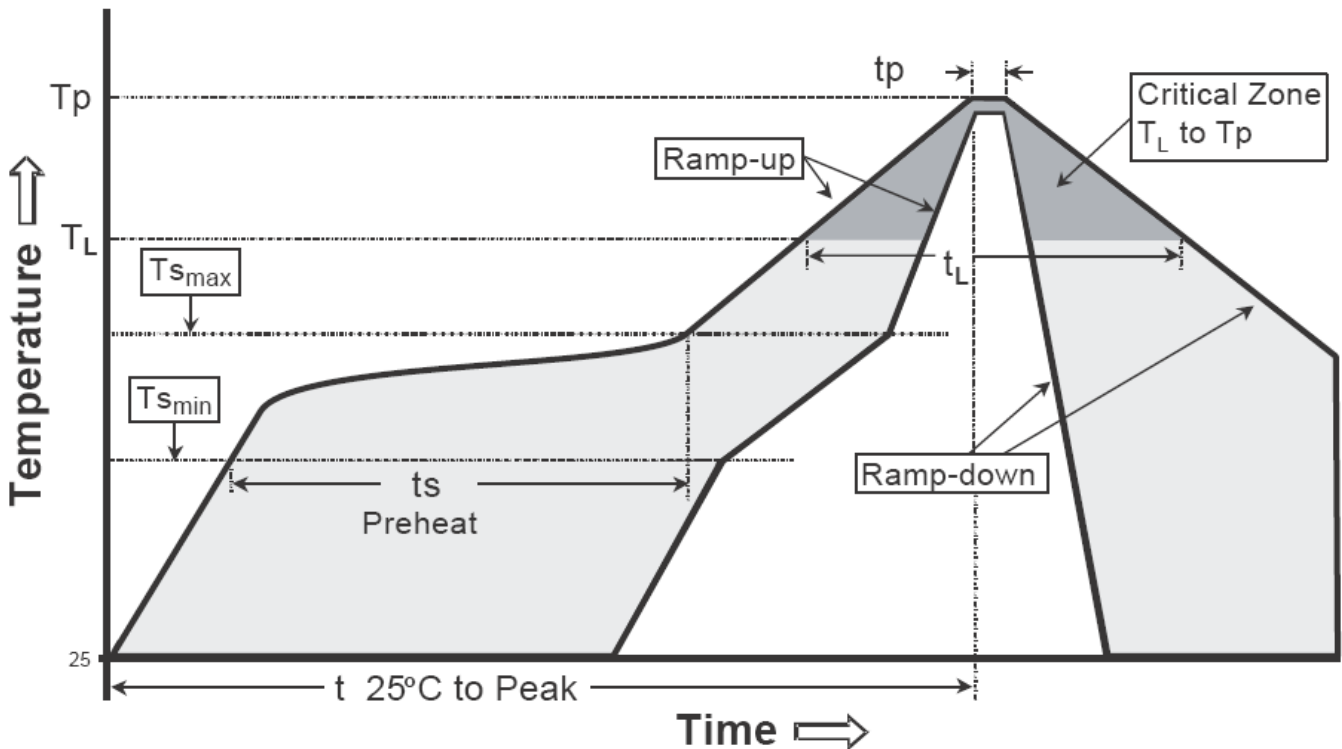
Carrier Tape Dimension



Recommended wave soldering condition

| | | |
|-----------------|------------------|-----------------|
| Product | Peak Temperature | Soldering Time |
| Pb-free devices | 260 +0/-5 °C | 5 +1/-1 seconds |

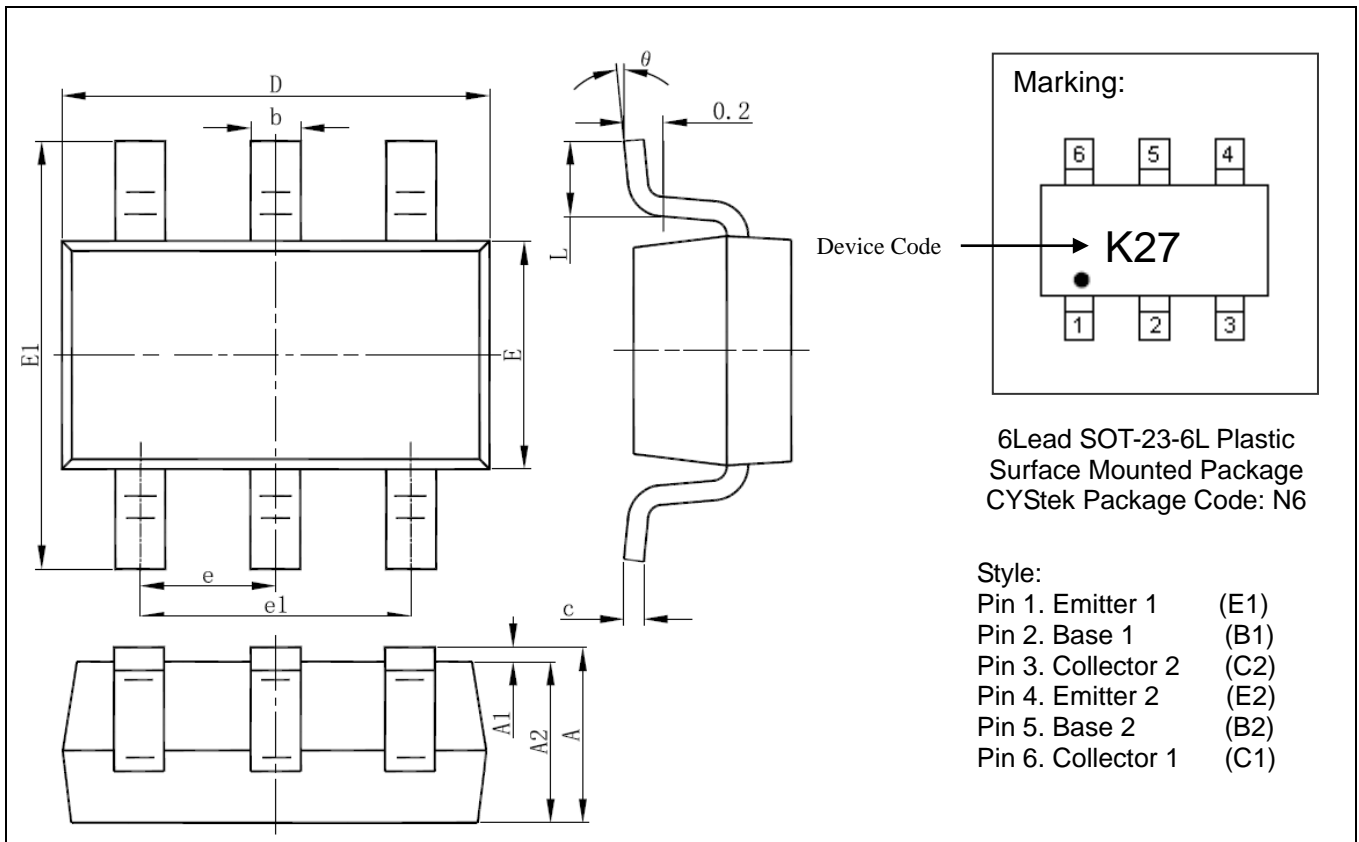
Recommended temperature profile for IR reflow



| Profile feature | Sn-Pb eutectic Assembly | Pb-free Assembly |
|--|-------------------------|------------------|
| Average ramp-up rate (Tsmax to Tp) | 3°C/second max. | 3°C/second max. |
| Preheat | | |
| -Temperature Min(Ts min) | 100°C | 150°C |
| -Temperature Max(Ts max) | 150°C | 200°C |
| -Time(ts min to ts max) | 60-120 seconds | 60-180 seconds |
| Time maintained above: | | |
| -Temperature (TL) | 183°C | 217°C |
| - Time (tL) | 60-150 seconds | 60-150 seconds |
| Peak Temperature(TP) | 240 +0/-5 °C | 260 +0/-5 °C |
| Time within 5°C of actual peak temperature(tp) | 10-30 seconds | 20-40 seconds |
| Ramp down rate | 6°C/second max. | 6°C/second max. |
| Time 25 °C to peak temperature | 6 minutes max. | 8 minutes max. |

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-23-6L Dimension



| DIM | Millimeters | | Inches | | DIM | Millimeters | | Inches | |
|-----|-------------|-------|--------|-------|-----|-------------|-------|-------------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| A | 1.050 | 1.250 | 0.041 | 0.049 | E | 1.500 | 1.700 | 0.059 | 0.067 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 | E1 | 2.650 | 2.950 | 0.104 | 0.116 |
| A2 | 1.050 | 1.150 | 0.041 | 0.045 | e | 0.950 (BSC) | | 0.037 (BSC) | |
| b | 0.300 | 0.500 | 0.012 | 0.020 | e1 | 1.800 | 2.000 | 0.071 | 0.079 |
| c | 0.100 | 0.200 | 0.004 | 0.008 | L | 0.300 | 0.600 | 0.012 | 0.024 |
| D | 2.820 | 3.020 | 0.111 | 0.119 | θ | 0° | 8° | 0° | 8° |

Notes : 1.Controlling dimension : millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

Important Notice:

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of CYStek.
- CYStek reserves the right to make changes to its products without notice.
- CYStek **semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- CYStek assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.